**HEWLETT-PACKARD COMPANY** Intellectual Property Administration P. O. Box 272400 Fort Collins, Colorado 80527-2400

## PATENT APPLICATION

ATTORNEY DOCKET NO. 10007804-1

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s):	Kuo, et al.	Confirmation No.:
Application No.:	:	Examiner:
Filing Date:	Sept 4, 2003	Group Art Unit:
Title:	A NODIZING PROCESS FOR IMPROVING ELECTRON EMIS DEVICES	SION IN ELECTRONIC
Commissioner for PO Box 1450 Alexandria, VA		
Sir:	ti Die Lee e Olehense Lie selberitte b	
	ation Disclosure Statement is submitted:	
(Wit	ler $37\ CFR\ 1.97(b)$ , or hin three months of filing national application; or date of entry of nating date of first office action on the merits; whichever occurs last)	tional application; or before
()	ler 37 CFR 1.97(c) together with either a: Statement under 37 CFR 1.97(e), or a \$180.00 fee under 37 CFR 1.17(p), or er the CFR 1.97 (b) time period, but before final action or notice of allow	ance, whichever occurs first)
()	ler 37 CFR 1.97 (d) together with a:  Statement under 37 CFR 1.97(e)(1) or (2), and a \$180.00 fee set forth in 37 CFR 1.17(p).  (Filed after final action, a notice of allowance, on or before payment of t	he issue fee)
pendency of th	rge to Deposit Account <b>08-2025</b> the sum of \$0.00 pis application, please charge any fees required or credit pursuant to 37 CFR 1.25.	
(V ) Applie	ant(s) submit harawith Form PTO 1/19. Information Dis	closure Citation togeth

ring the Deposit

Applicant(s) submit herewith Form PTO 1449 Intermation Disclosure Citation together with copies, of patents, publications or other information of which applicant(s) are aware, which applicant(s) believe(s) may be material to the examination of this application and for which there may be a duty to disclose in accordance with 37 CFR 1.56.

( ) A concise explanation of the relevance of foreign language patents, foreign language publications and other foreign language information listed on PTO Form 1449, as presently understood by the individuals(s) designated in 37 CFR 1.56 (c) most knowledgeable about the content is given on the attached sheet, or where a foreign language patent is cited in a search report or other action by a foreign patent office in a counterpart foreign application, an English language version of the search report or action which indicates the degree of relevance found by the foreign office is listed on form PTO 1449 and is enclosed herewith.

It is requested that the information disclosed herein be made of record in this application.

"Express Mail" label no. EL 980208678 US

Date of Deposit Sept 4, 2003

I hereby certify that this is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 CFR 1.10 on the date indicated above and is addressed to: Commissioner for Patents, Washington, D.C. 20231.

Typed Name: Vaughn W. North

Respectfully submitted,

Kuo, et al.

Vaughn W. North

Attorney/Agent for Applicant(s)

Reg. No. 27,930

Date: Sept 4, 2003

Telephone No.: (801) 566-6633

## PATENT APPLICATION

Sheet 1 of 1

			FORM PTO-1449						
	LIST OF PATENTS AND PUBLICATIONS FOR					ــــــــــــــــــــــــــــــــــــــ			
A PPLICANT'S INFORMATION DISCLOSURE STATEMENT  (Use several sheets if necessary)				APPLICANT  Kuo, et al.					
				FILING DATE	GROUP		<del></del>		
				Sept 4, 2003					
REFERENCE D	ESIGNATION	U.S. P/	ATENT	DOCUMENTS					
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	OTHER REF	ERENCES (includi	ng Aut	thor, Title, Date, P	Pertinent Pages, etc.	)			
1Q	Halimaoui; Po Science and T	prous Silicon: Mater echnology; (1994)	ial proc Lecture	essing, properties a	nd applications.; Poro	us Silicon			
1R	Sheng, et al.; Improved cold elecron emission characteristics of electroluminescent porous silicon diodes; J. Vac. Science Technology (1997); pgs. 1661-1665								
18	Sheng, et al.; Efficient and ballistic cold electron emission from porous polycrystalline silicon diodes with a porosity multilayer structure; J. Vac. Science Technology; (2001) pgs 64-67								
EXAMINER	<u> </u>	<del></del>		DATE CONSIDER					

Rev 05.03 (PT01449)